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Bib Data Sheet

CONFIRMATION NO. 2502

<b>SERIAL NUMBER</b> 10/040,710	<b>FILING DATE</b> 12/28/2001 <b>RULE</b>	<b>CLASS</b> 382	<b>GROUP ART UNIT</b> 2621	<b>ATTORNEY DOCKET NO.</b> TAIYO.YAMAGATA.PT1
<b>APPLICANTS</b> Toshiyuki Sato, Yamagata-shi, JAPAN; Soichi Yamamoto, Tendo-shi, JAPAN; Tsuneyoshi Goto, Tendo-shi, JAPAN; Hiroshi Arai, Tendo-shi, JAPAN;				
<b>** CONTINUING DATA *****</b> <i>None</i>				
<b>** FOREIGN APPLICATIONS *****</b> JAPAN 2001-273059 09/10/2001 JAPAN 2001-284994 09/19/2001 JAPAN 2001-284995 09/19/2001 JAPAN 2001-293134 09/26/2001				
<b>IF REQUIRED, FOREIGN FILING LICENSE GRANTED</b> <b>** 02/05/2002</b>				
Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no 35 USC 119 (a-d) conditions met <input type="checkbox"/> yes <input checked="" type="checkbox"/> no <input type="checkbox"/> Met after Allowance Verified and Acknowledged <i>[Signature]</i> Examiner's Signature Initials		<b>STATE OR COUNTRY</b> JAPAN	<b>SHEETS DRAWING</b> 27	<b>TOTAL CLAIMS</b> 30
<b>INDEPENDENT CLAIMS</b> 7				
<b>ADDRESS</b> Otto O. Lee, Esq. Intellectual Property Law Group LLP 12th Floor 12 South First Street San Jose, CA 95051				
<b>TITLE</b> Grain quality judging sample container, grain quality judger, grain quality judging system, grain image reading device, sample arraying jig for the grain image reading device, sample arraying method, and sample arrayer for the grain image reading device				
<b>FILING FEE RECEIVED</b> 1256	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:		<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees ( Filing ) <input type="checkbox"/> 1.17 Fees ( Processing Ext. of time ) <input type="checkbox"/> 1.18 Fees ( Issue ) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit	